


Search Notes 	Application/Control No. 10617530	Applicant(s)/Patent Under Reexamination CHEN ET AL.
	Examiner Neway, Samuel G	Art Unit 2626

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST: Text Search, PLUS Search	12/21/06	SN
EAST: Inventor, Assignee Search	12/21/06	SN
Consulted: John Peng, QAS, for 101, 112 issues	1/09/07	SN
Consulted: Talivaldis Smits, AU 2626	1/09/07	SN
EAST: Text Search	05/07/07	SN
NPL Search	05/08/07	SN

INTERFERENCE SEARCH			
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